		DARD							
RATING	OPERATING TEMPERATURE RANGE VOLTAGE CURRENT		-55 °C TO 125 °C (N	IOTES 1)	STORAGE TEMPERAT	URE RANGE	-10 °C TO 60 °C (NO)TES 2	2)
			50 V AC						
CURRENT									
			SPE	CIFICAI	IONS				1
	ΓEM		TEST METHOD			REQI	JIREMENTS	QT	A
CONSTR									
GENERAL EX	AMINATION		AND BY MEASURING INSTR	UMENT.	ACCO	ORDING TO	DRAWING.	X)
MARKING		CONFIRMED VISUALLY.)
ELECTR	IC CHARA	CTERIS	STICS						
CONTACT RESISTANCE		20 mV AC OR LESS 1 kHz, 1 mA.			50 m	50 mΩ MAX.			-
NSULATION RESISTANCE		100 V DC			500 N	500 MΩ MAX			-
VOLTAGE PROOF		150 V AC FOR 1 min.			NO F	NO FLASHOVER OR BREAKDOWN.			-
MECHAN	ICAL CHAR	ACTERI	STICS						-
-	OPERATION	-	SINSERTIONS AND WITH	HDRAWALS	. ① C	ONTACT RE	SISTANCE: 50 mΩ MAX	X	-
					2 NC	2 NO DAMAGE, CRACK AND LOOSENESS OF PARTS.			
/IBRATION		FREQUENCY 10 TO 55 Hz, SINGLE AMPLITUDE			0	(1) NO ELECTRICAL DISCONTINUITY OF 1 μ s.			-
SHOCK		0.75 mm, AT 2 h, FOR 3 DIRECTIONS.				② NO DAMAGE, CRACK AND LOOSENESS OF PARTS.			
		490 m/s ² DURATION OF PULSE 11 ms AT 3 TIMES FOR 3 DIRECTIONS.							-
	IMENTAL C				(2) NO	D DAMAGE, CRA	CK AND LOOSENESS OF PARTS.		
		1		25 →15 TO 3F	<u></u>	NTACT RESU	STANCE: 50 mO MAX	X	Τ.
RAPID CHANGE OF TEMPERATURE		TEMPERATURE -65 \rightarrow 15TO 35 \rightarrow 125 \rightarrow 15TO 35 °CTIME30 \rightarrow 2TO 3 \rightarrow 30 \rightarrow 2TO 3 min				 CONTACT RESISTANCE: 50 mΩ MAX. INSULATION RESISTANCE: 500 MΩ MIN. 			
		UNDER 5 CYCLES.				③ NO DAMAGE, CRACK AND LOOSENESS OF PARTS.			
DAMP HEAT (STEADY STATE) SULPHUR DIOXIDE		EXPOSED AT 40 ± 2 °C, 90 TO 95 %, 96 h.			-				-
					-	 ② INSULATION RESISTANCE: 500 MΩ MIN. ③ NO DAMAGE, CRACK AND LOOSENESS OF PARTS. 			
		EXPOSED IN 25 PPM RH 75 % FOR 96 h.				(1) CONTACT RESISTANCE: 50 m Ω MAX.			-
	STANCE OF		ANDARD:JEIDA-38) MENDED TEMPERATURE		-	HEAVY COR	ROSION. OF CASE OF EXCESSIVE	X	
SOLDERING		 (SOLDERING AREA) MAX250°C, 220°C FOR 60 SECONDS MAX. (PREHEATING AREA) 150 TO 180°C 90~120 SECONDS. MAXIMUM TWICE ACTION IS ALLOWED UNDER THE SAME CONDITION. [RECOMMENDED MANUAL SOLDELING CONDITION] SOLDERING IRON TEMPERATURE 350°C SOLDERING TIME : WITHIN 3 SECONDS. 			THE	ENESS OF T	IE TERMINALS.		
NOTES1:INCL NOTES2:STO	RAGEIS DEFIN	ED AS LONG	E RISE BY CURRENT. 3-TERM STORAGE OF UNUS NGE TO PRODUCTS MOUNT			WER SUPLLY	·.		
NOTES2:STO APPLY OPER	RAGEIS DEFIN	ED AS LONG RATURE RAI	G-TERM STORAGE OF UNUS			WER SUPLLY	·.		
NOTES1:INCL NOTES2:STO APPLY OPER JNLESS OTH COUN	RAGEIS DEFINI ATION TEMPEF	ED AS LONG RATURE RAI IFIED , REFE	G-TERM STORAGE OF UNUS NGE TO PRODUCTS MOUNT	FED ON PCB \		WER SUPLLY	CHECKED	DA	ATE
NOTES1:INCL NOTES2:STO APPLY OPER JNLESS OTH	RAGEIS DEFINI ATION TEMPEF	ED AS LONG RATURE RAI IFIED , REFE	G-TERM STORAGE OF UNUS NGE TO PRODUCTS MOUNT ER TO JIS C 5402 .	FED ON PCB \	WITHOUT PC	WER SUPLLY		DA	ATE
NOTES1:INCL NOTES2:STO APPLY OPER JNLESS OTH COUN	RAGEIS DEFINI ATION TEMPEF	ED AS LONG RATURE RAI IFIED , REFE	G-TERM STORAGE OF UNUS NGE TO PRODUCTS MOUNT ER TO JIS C 5402 .	FED ON PCB \	WITHOUT PC		CHECKED	DA 2020	
NOTES1:INCL NOTES2:STO APPLY OPER JNLESS OTH COUN	RAGEIS DEFINI ATION TEMPEF	ED AS LONG RATURE RAI IFIED , REFE	G-TERM STORAGE OF UNUS NGE TO PRODUCTS MOUNT ER TO JIS C 5402 .	FED ON PCB \	WITHOUT PC	APPROVE	CHECKED ED WR. FUKUCHI D TS. MIYAZAKI		007
NOTES1:INCL NOTES2:STO APPLY OPER JNLESS OTH COUN	RAGEIS DEFINI ATION TEMPEF	ED AS LONG RATURE RAI IFIED , REFE	G-TERM STORAGE OF UNUS NGE TO PRODUCTS MOUNT ER TO JIS C 5402 .	FED ON PCB \	WITHOUT PC	APPROVE	CHECKED ED WR. FUKUCHI D TS. MIYAZAKI	2020)07)07
NOTES1:INCL NOTES2:STO APPLY OPER UNLESS OTH COUN	RAGEIS DEFINI ATION TEMPEF	ED AS LONG RATURE RAI IFIED , REFE	G-TERM STORAGE OF UNUS NGE TO PRODUCTS MOUNT ER TO JIS C 5402 .	FED ON PCB \	WITHOUT PC	APPROVE	CHECKED ED WR. FUKUCHI D TS. MIYAZAKI ED KT. KUSAKA	2020 2020)07)07)07
NOTES1:INCL NOTES2:STO APPLY OPER JNLESS OTH COUN	RAGEIS DEFINI ATION TEMPER IERWISE SPEC IT DI	ED AS LONG RATURE RAI IFIED , REFE ESCRIPTIC	G-TERM STORAGE OF UNUS NGE TO PRODUCTS MOUNT ER TO JIS C 5402 .		DESIGNED	APPROVE CHECKE DESIGNE	CHECKED ED WR. FUKUCHI D TS. MIYAZAKI ED KT. KUSAKA	2020 2020 2020 2020)07)07)07)07
NOTES1:INCL NOTES2:STO APPLY OPER JNLESS OTH COUN	RAGEIS DEFINI ATION TEMPER IERWISE SPEC IT DI	ED AS LONG RATURE RAI IFIED , REFE ESCRIPTIC	G-TERM STORAGE OF UNUS NGE TO PRODUCTS MOUNT ER TO JIS C 5402 . ON OF REVISIONS	Test	DESIGNED	APPROVE CHECKE DESIGNE DRAWN NG NO.	CHECKED D WR. FUKUCHI D TS. MIYAZAKI D KT. KUSAKA I RN. IIDA	2020 2020 2020 2020 2020 1-0)07)07)07)07
NOTES1:INCL NOTES2:STO NPPLY OPER JNLESS OTH COUN	RAGEIS DEFINI ATION TEMPER	ED AS LONG RATURE RAI IFIED , REFE ESCRIPTIC	G-TERM STORAGE OF UNUS NGE TO PRODUCTS MOUNT ER TO JIS C 5402 . ON OF REVISIONS	Test	DESIGNED	APPROVE CHECKE DESIGNE DRAWN NG NO. DF1	CHECKED D WR. FUKUCHI D TS. MIYAZAKI D KT. KUSAKA I RN. IIDA ELC-389181-5 2NB (3. 0) -80DS-0. 5V	2020 2020 2020 2020 1-0 (51))07)07)07)07